

ECE 6453 HW#3 Solutions

ECE6453
HW 3
Solutions

PL

1. a) $G_{L0} = 10^{13} \text{ EHP/cm}^3 < N_D (10^{14} \text{ cm}^{-3}) \Rightarrow \text{low-level injection}$

From minority continuity equation, we have

$$\frac{\partial \Delta n_p}{\partial t} = D_n \frac{\partial^2 \Delta n_p}{\partial x^2} + \mu_n \cancel{\mathcal{E}} \frac{\partial \Delta n_p}{\partial x} - \frac{\Delta n_p}{\tau_n} + G_0$$

(uniform distribution)

(i) @ steady state: $\frac{\partial \Delta n_p}{\partial t} = 0,$

$$\Rightarrow \Delta n_p = G_0 \cdot \tau_n = G_{L0} = 10^{13} \text{ cm}^{-3}$$

(ii) $t > 0$, light $\rightarrow G_{L0}$ reduced to half

$$\frac{\partial \Delta n_p}{\partial t} = -\frac{\Delta n_p}{\tau_n} + G_0/2$$

$$\Rightarrow \Delta n_p(t) = A \exp(-t/\tau_n) + B$$

B.C. $t=0 \quad \Delta n_p = G_{L0}$

$t=\infty \quad \Delta n_p = G_{L0}/2$

$$\Rightarrow \Delta n_p(t) = \frac{G_{L0}}{2} [1 + \exp(-t/\tau_n)]$$
$$= 5 \times 10^{12} [1 + \exp(-t \times 10^6)] (\text{cm}^{-3})$$

b) Minority carrier diffusion equation at work here.

under steady state: $0 = \frac{\partial \Delta p_n}{\partial t} = D_p \frac{\partial^2 \Delta p_n}{\partial x^2} - \frac{\Delta p_n}{\tau_p} + G_0 \exp(-\alpha x)$

where α is the absorption coefficient of the semiconductor at the light wavelength.

Solve for ^{this} equation, we have

$$\Delta P_n(x) = \tau_p G_0 \left[\frac{\alpha^2 L_p^2}{1 - \alpha^2 L_p^2} \exp(-x/L_p) + \frac{1}{1 - \alpha^2 L_p^2} \exp(-\alpha x) \right]$$

$$L_p = \sqrt{\tau_p D_p}$$

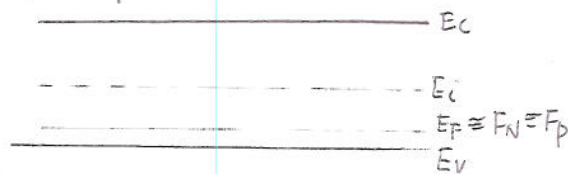
At $t=0$, the light source turned off. The new equation to solve is:

$$\frac{\partial \Delta P_n}{\partial t} = D_p \frac{\partial^2 \Delta P_n}{\partial x^2} - \frac{\Delta P_n}{\tau_p}$$

$$\text{with B.C.'s } \begin{cases} \Delta P_n(x, 0) = \tau_p G_0 \left[\frac{\alpha^2 L_p^2}{1 - \alpha^2 L_p^2} \exp(-x/L_p) + \frac{1}{1 - \alpha^2 L_p^2} \exp(-\alpha x) \right] \\ \Delta P_n(x, \infty) = 0 \end{cases}$$

2. (a) Note that this is a majority carrier injection. Since it is low-level injection, $p \approx p_0$ and $n = n_0$ (no minority carrier injection).

Therefore $E_n = E_F \approx E_p$



- (b) The majority continuity equation becomes:

$$\frac{\partial \Delta p}{\partial t} = D_p \frac{\partial^2 \Delta p}{\partial x^2} - \mu_p E \frac{\partial \Delta p}{\partial x} - \mu_p p \frac{\partial \mathcal{E}}{\partial x} - \frac{\Delta p}{\tau_p}$$

Look at each term on the right hand side.. we may first assume $\Delta p \propto e^{-x/L_p}$

$$\langle i \rangle D_p \frac{\partial^2 \Delta p}{\partial x^2} \propto \frac{D_p}{L_p^2} \Delta p \approx 10^7 \Delta p$$

$$\langle ii \rangle -\mu_p E \frac{\partial \Delta p}{\partial x} \propto \mu_p / L_p E \Delta p \approx 4 \times 10^5 E \Delta p, (E \approx 0)$$

$$\langle iii \rangle \mu_p p \frac{\partial \mathcal{E}}{\partial x}: p = p_0 + \Delta p \approx p_0, \frac{\partial \mathcal{E}}{\partial x} = \frac{p}{\epsilon_s} \approx \frac{q \Delta p}{\epsilon_s} \quad \leftarrow \text{Poisson's equation}$$

$$\Rightarrow \mu_p p \frac{\partial \mathcal{E}}{\partial x} = \frac{q p_0}{\epsilon_s} \Delta p \approx 5 \times 10^{10} \Delta p$$

From this estimation, one may see that the 3rd term dominates the overall transportation process for majority carriers. One can define a

"relaxation time" as $(q p_0 / \epsilon_s)^{-1} = \tau_{\text{relax}}$

The equation can be simplified as

$$\frac{\partial \Delta P}{\partial t} \approx \frac{\partial \Delta P}{\partial t} \approx -\frac{\Delta P}{\tau_{relax}}$$

$$\Rightarrow \Delta P_p(t) = \Delta P_{p0} \exp(-t/\tau_{relax})$$

This means that, for majority carrier injection, the excess carrier transport is due to a process called "relaxation" with a relaxation time constant of (ϵ_s/σ) . The excess ^{majority} carrier will decay exponentially at very short period of time (in this case $\sim 10ps$) and appear at the end of the semiconductor bar. This is a process that is very different from the minority carrier injection.

(c) Sorry for the typo.. It should have been "excess electrons", not "excess hole injection". So... if $\Delta n(x,t) = 10^7 \delta(x) \delta(t) \dots$

$V=20V$, $E = V/d = 100 V/cm$. From the velocity vs. electric field chart, we can assure that the low-field mobility approximation is valid, and the minority carrier continuity equation may still hold true. So, the equation used in Haynes-Shockley exp. can be applied.

$$\Rightarrow \Delta n_p(x,t) = \frac{N}{\sqrt{4D_n t}} \exp\left(-\frac{(x - \mu_n E t)^2}{4D_n t} - t/\tau_n\right)$$

(d) $\Delta t = x/v_d = 1.059 ns$

(e) As calculated in (d), the decrease of excess minority carrier through recombination is insignificant $e^{-(\Delta t/\tau_n)} = e^{-1.059 \times 10^{-10} / 10^{-7}} \approx 1$

The spreading of the pulse is mostly coming from diffusion ~~diff~~.

$FWHM = 2\sqrt{\ln 2} \sqrt{4D_n t_0} / v_d$, t_0 is the time interval between the excitation and the detection of peak amplitude at site x_i

\therefore @ x_1 , $FWHM = 0.63 (ns)$

@ x_2 , $FWHM = 1.99 (ns)$

@ $x_3 = 1\text{mm}$, $t_0 = 1.17 \times 10^{-7}\text{s} \sim \tau_n$, one will expect the peak amplitude is $\propto \frac{1}{\sqrt{t}} \exp(-t/\tau_n)$ of original value

(f) if $\mathcal{E} = V/l = \frac{2}{1 \times 10^{-4}} = 20 \text{ kV/cm}$, The electron velocity will approach a saturation value. The drift current component is determined by

$J_{\text{drift}} = q n \bar{v}_{\text{sat}}$. So the continuity equation may be written as

$$\text{as } \left[D_n \frac{\partial^2 \Delta n_p}{\partial x^2} + \bar{v}_{\text{sat}} \frac{\partial \Delta n_p}{\partial x} + G - \frac{\Delta n_p}{\tau_n} = \frac{\partial \Delta n_p}{\partial t} \right]$$

Further simplification follows. Since $l = 1\mu\text{m} \ll L_N (= \sqrt{\tau_n D_n})$. The metal contact at the end of the semiconductor bar will force an extraction of excess carriers, i.e. $\Delta n_p(x=1\mu\text{m}) = 0$. A linear approximation may be used to describe the excess carrier profile in this system. So... $\frac{\partial^2 \Delta n_p}{\partial x^2} \approx 0$

If there is no light or excess carrier excitation, $G = 0$.

The B.C. for solving this equation are:

$$\begin{cases} \Delta n_p(x, t) |_{x=0} = \Delta n_{p0} \\ \Delta n_p(x, t) |_{x=1\mu\text{m}} = 0 \end{cases}$$

Note: In real world, τ_n (minority carrier life time) $\sim 10^{-9}\text{s}$ range. So you are looking at a wider pulse and ~~shorter~~ shorter diffusion length.